

**Search Notes**

Application/Control No.

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Examiner

B. Dell Chism

Applicant(s)/Patent under  
Reexamination

ZHELEVA ET AL.

Art Unit

1654

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC (sequence search)	5/5/2006	BDC